


<b>Search Notes</b> 	<b>Application/Control No.</b> 10671718	<b>Applicant(s)/Patent Under Reexamination</b> OGAWA ET AL.
	<b>Examiner</b> PAUL KIM	<b>Art Unit</b> 2169

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search in all DBs for threshold input.	1/18/2009	pk
EAST Search in all DBs for sort variables and re-sorting according to said sort variables.	1/18/2009	pk

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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